

2M BIT (256K WORD × 8 BIT) CMOS MASK ROM

DESCRIPTION

The TC532000AP/AF is a 2,097,152 bits read only memory organized as 262,144 words by 8bits.

The TC532000AP/AF is fabricated using Toshiba's advanced CMOS technology which provides the high speed and low power features with access time of 150ns, an operation current of 40mA at 6.7MHz and a standby current of 20µA.

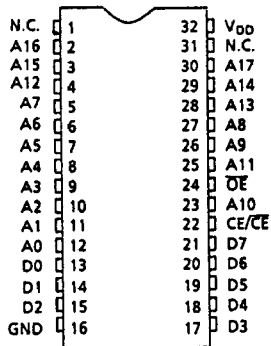
The TC532000AP/AF has one programmable chip enable input \overline{CE}/CE for device selection.

The TC532000AP/AF is packaged in a standard 600mil 32pin DIP or 525mil 32pin SOP.

FEATURES

- Single 5V Power Supply
- Access Time : 150ns (Max.) $V_{DD}=5V \pm 10\%$
- Power Dissipation
 - Operating Current : 40mA (Max.)
 - Standby Current : 20µA (Max.)
- All Inputs and Outputs : TTL Compatible
- Three State Outputs
- Fully Static Operation
- Programmable Chip Enable
- TC532000AP : DIP32 - P - 600
- TC532000AF : SOP32 - P - 525

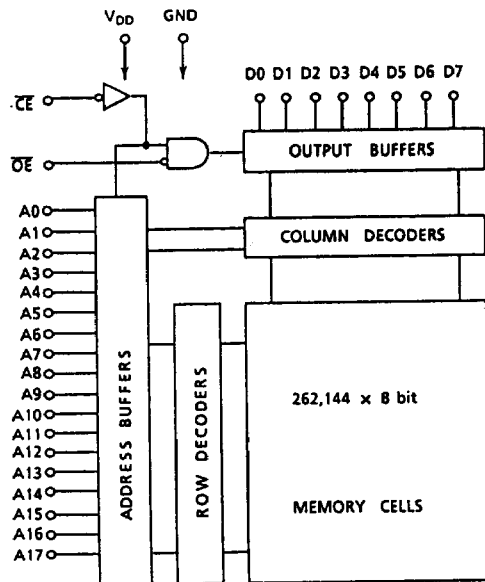
PIN CONNECTION



PIN NAMES

A0~A17	Address inputs
D0~D7	Data Outputs
\overline{OE}	Output Enable Input
CE/ \overline{CE}	Chip Enable Input
V _{DD}	Power Supply
GND	Ground
N.C.	No Connection

BLOCK DIAGRAM



MAXIMUM RATINGS

SYMBOL	ITEM	RATING	UNIT
V _{DD}	Power Supply Voltage	-0.5~7.0	V
V _{IN}	Input Voltage	-0.5~V _{DD}	V
V _{OUT}	Output Voltage	0~V _{DD}	V
P _D	Power Dissipation	1.0/0.6*	W
T _{STG}	Storage Temperature	-55~150	°C
T _{OPR}	Operating Temperature	0~70	°C
T _{SOLDER}	Soldering Temperature · Time	260 · 10	°C · sec

Note : * Plastic FP.

D.C. OPERATING CONDITIONS (Ta = 0~70°C)

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V _{DD}	Power Supply Voltage	4.5	5.5	V
V _{IH}	Input High Voltage	2.2	V _{DD} + 0.3	V
V _{IL}	Input Low Voltage	-0.3	0.8	V

D.C. and OPERATING CHARACTERISTICS (V_{DD} = 5V ± 10% , Ta = 0~70°C)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
I _{IL}	Input Leakage Current	V _{IN} = 0~V _{DD}	-	± 1.0	μA
I _{LO}	Output Leakage Current	$\overline{CE} = V_{IH}$, V _{OUT} = 0~V _{DD}	-	± 5.0	μA
I _{OH}	Output High Current	V _{OH} = 2.4V	-1.0	-	mA
I _{OL}	Output Low Current	V _{OL} = 0.4V	2.0	-	mA
I _{DDs1}	Standby Current	$\overline{CE} = V_{IH}$	-	2	mA
I _{DDs2}		$\overline{CE} = V_{DD}$ and V _{IN} = 0V (V _{DD})	-	20	μA
I _{DDO1}	Operating Current	V _{IN} = V _{IH} / V _{IL} , t _{cycle} = 150ns	-	50	mA
I _{DDO2}		V _{IN} = V _{DD} / 0V, t _{cycle} = 150ns	-	40	mA

CAPACITANCE

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
C _{IN}	Input Capacitance	f = 1MHz, Ta = 25°C	-	10	pF
C _{OUT}	Output Capacitance	f = 1MHz, Ta = 25°C	-	10	pF

Note : This Parameter is periodically sampled and is not 100% tested.

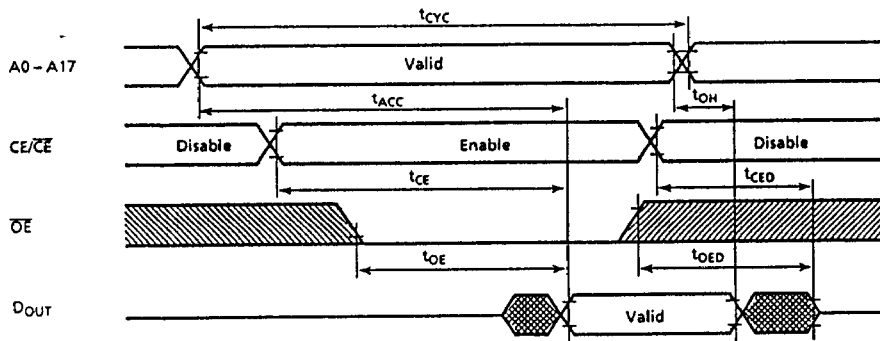
A.C. CHARACTERISTICS

SYMBOL	PARAMETER	· MIN.	MAX.	UNIT
t_{ACC}	Access Time	-	150	ns
t_{CE}	Chip Enable Access Time	-	150	ns
t_{OE}	Output Enable Access Time	-	70	ns
t_{CED}	Output Disable Time from \overline{CE}	0	60	ns
t_{OED}	Output Disable Time from \overline{OE}	0	60	ns
t_{OH}	Output Hold Time	5	-	ns
t_{CYC}	Cycle Time	150	-	ns

A.C. TEST CONDITIONS

Output Load : 100pF + 1TTL
 Input Levels : 0.6V , 2.4V
 Timing Measurement Reference Levels Input : 0.8V , 2.2V
 Output : 0.8V , 2.0V
 Input Rise and Fall Time : 5ns

TIMING WAVEFORMS



OPERATION MODE

MODE	\overline{CE} (CE)	\overline{OE}	A0~A17	Outputs	Power
Read	L (H)	L	Valid	Data Out	Operating
Standby	H (L)	*	*	High-Z	Standby
Output Deselect	L (H)	H	*	High-Z	Operating

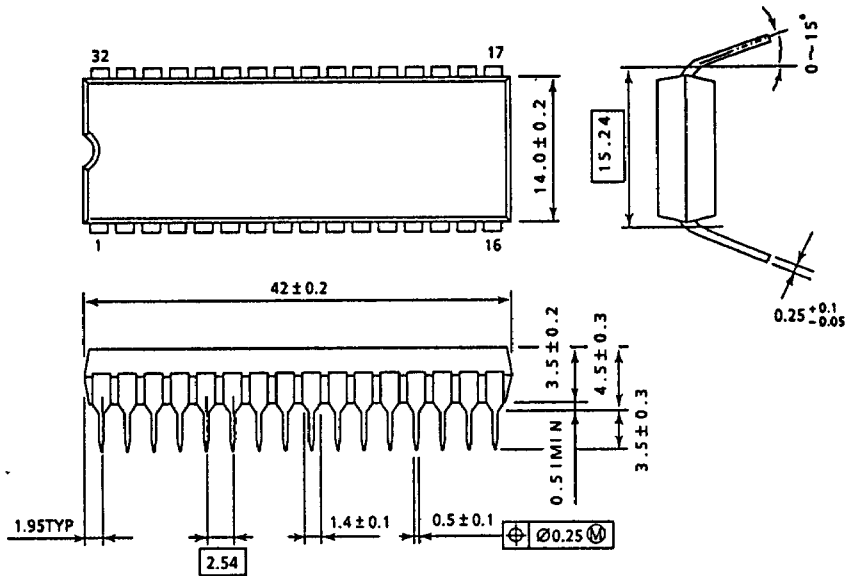
H : VIH L : VIL * : VIH or VIL

TC532000AP/AF-15

OUTLINE DRAWINGS

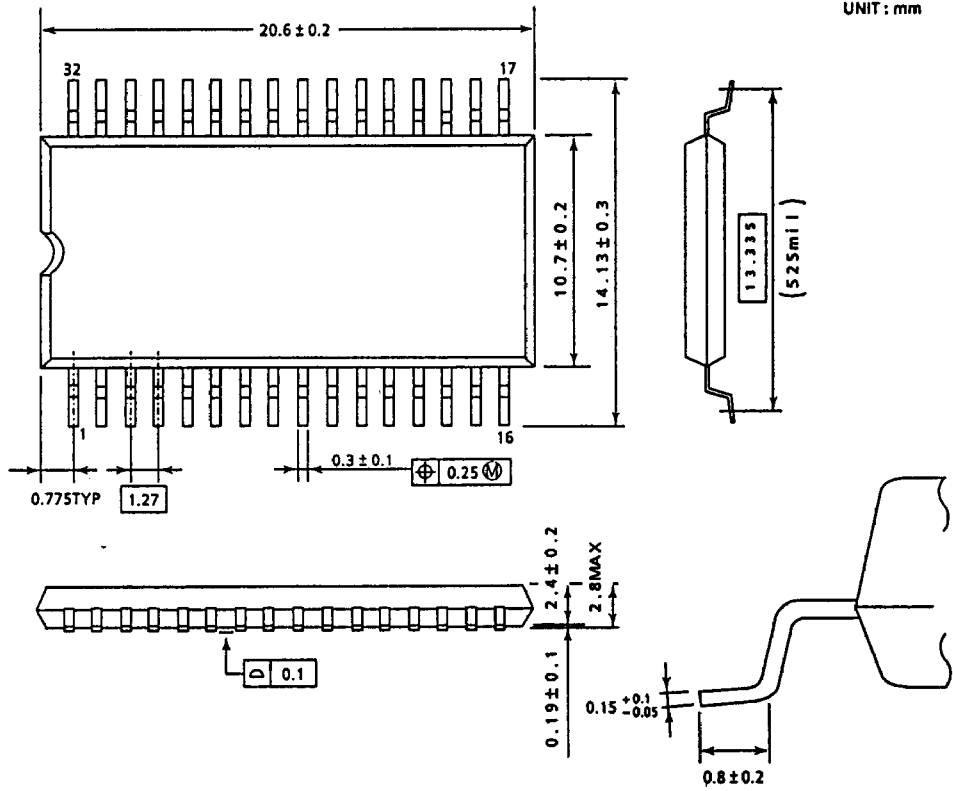
Plastic DIP (DIP32-P-600)

UNIT : mm



Note: Package width and length do not include mold protrusion, allowable mold protrusion is 0.15mm.

OUTLINE DRAWINGS
Plastic FP (SOP32-P-525)



Note: Package width and length do not include mold protrusion, allowable mold protrusion is 0.15mm.